

### General Description

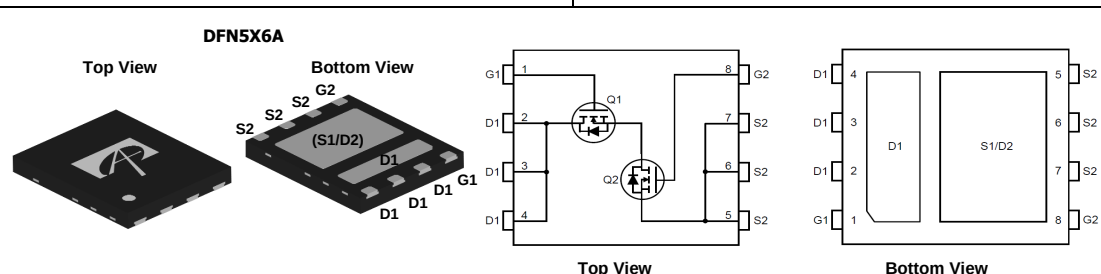
The AON6922 is designed to provide a high efficiency synchronous buck power stage with optimal layout and board space utilization. It includes two specialized MOSFETs in a dual Power DFN5x6A package. The Q1 "High Side" MOSFET is designed to minimize switching losses. The Q2 "Low Side" MOSFET is designed for low  $R_{DS(ON)}$  to reduce conduction losses. The AON6922 is well suited for use in compact DC/DC converter applications.

### Product Summary

|                                    | Q1             | Q2             |
|------------------------------------|----------------|----------------|
| $V_{DS}$                           | 25V            | 25V            |
| $I_D$ (at $V_{GS}=10V$ )           | 71A            | 85A            |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )    | <3.8m $\Omega$ | <1.4m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS} = 4.5V$ ) | <4.8m $\Omega$ | <1.8m $\Omega$ |

100% UIS Tested

100% Rg Tested



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol           | Max Q1     | Max Q2 | Units            |
|------------------------------------------------|------------------|------------|--------|------------------|
| Drain-Source Voltage                           | $V_{DS}$         | 25         |        | V                |
| Gate-Source Voltage                            | $V_{GS}$         | $\pm 12$   |        | V                |
| Continuous Drain Current <sup>G</sup>          | $I_D$            | 71         | 85     | A                |
| $T_C=25^\circ\text{C}$                         |                  | 44         | 66     |                  |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$         | 240        | 420    | A                |
| Continuous Drain Current                       | $I_{DSM}$        | 18         | 31     | A                |
| $T_A=25^\circ\text{C}$                         |                  | 14         | 25     |                  |
| Avalanche Current <sup>C</sup>                 | $I_{AS}, I_{AR}$ | 40         | 78     | A                |
| Avalanche Energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 80         | 304    | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$            | 31         | 104    | W                |
| $T_C=25^\circ\text{C}$                         |                  | 12.5       | 41.5   |                  |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$        | 2          | 2.2    | W                |
| $T_A=25^\circ\text{C}$                         |                  | 1.3        | 1.4    |                  |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$   | -55 to 150 |        | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ Q1 | Typ Q2 | Max Q1 | Max Q2 | Units              |
|--------------------------------------------|-----------------|--------|--------|--------|--------|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 25     | 20     | 30     | 25     | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A D</sup> |                 | 50     | 45     | 60     | 55     | $^\circ\text{C/W}$ |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 3.1    | 0.9    | 4      | 1.2    | $^\circ\text{C/W}$ |

**Q1 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                                   | Min  | Typ      | Max        | Units |
|-----------------------------|---------------------------------------|----------------------------------------------------------------------------------------------|------|----------|------------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                              |      |          |            |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                                   | 25   |          |            | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =25V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                            |      |          | 1<br>5     | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±12V                                                  |      |          | 100        | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                     | 0.7  | 1.2      | 1.7        | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V                                                    | 240  |          |            | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                           |      | 3<br>4.3 | 3.8<br>5.4 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A                                                   |      | 3.7      | 4.8        | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A                                                     |      | 125      |            | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                      |      | 0.7      | 1          | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                              |      |          | 30         | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                              |      |          |            |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =12.5V, f=1MHz                                          | 1560 | 1950     | 2340       | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                              | 530  | 755      | 980        | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |                                                                                              | 20   | 70       | 120        | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                             | 0.7  | 1.4      | 2.1        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                              |      |          |            |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =12.5V, I <sub>D</sub> =20A                            | 21   | 26.5     | 32         | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |                                                                                              | 9    | 11.2     | 13.4       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                              |      | 2.7      |            | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                              |      | 4        |            | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =12.5V,<br>R <sub>L</sub> =1.25Ω, R <sub>GEN</sub> =3Ω |      | 5.5      |            | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                              |      | 3.5      |            | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                              |      | 30       |            | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                              |      | 4        |            | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A, dI/dt=500A/μs                                                           | 12   | 15       | 18         | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, dI/dt=500A/μs                                                           | 20   | 25       | 30         | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

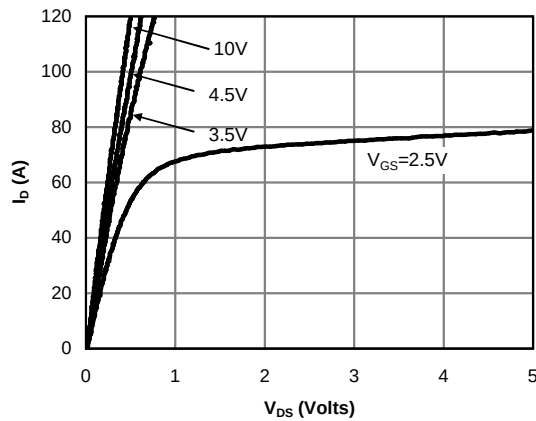
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

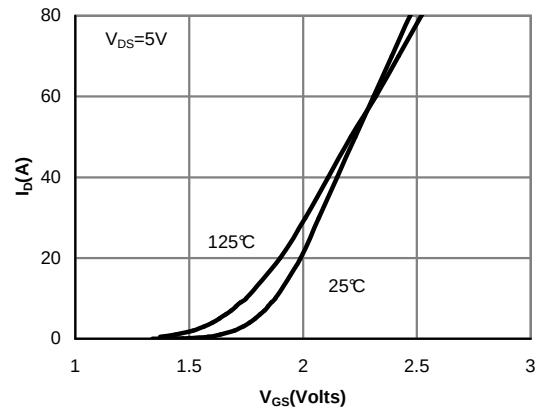
H. These tests are performed with the device mounted on 1 in2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.

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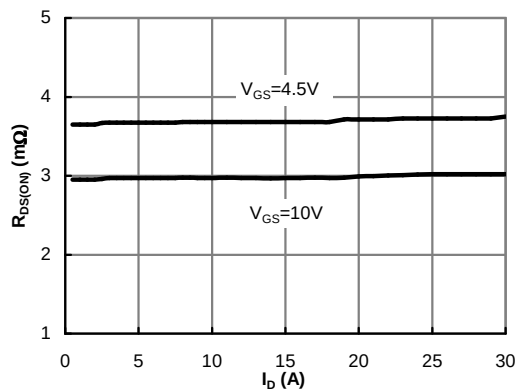
**Q1-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



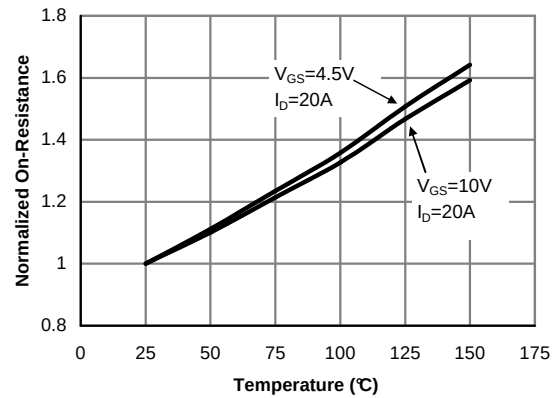
**Fig 1: On-Region Characteristics (Note E)**



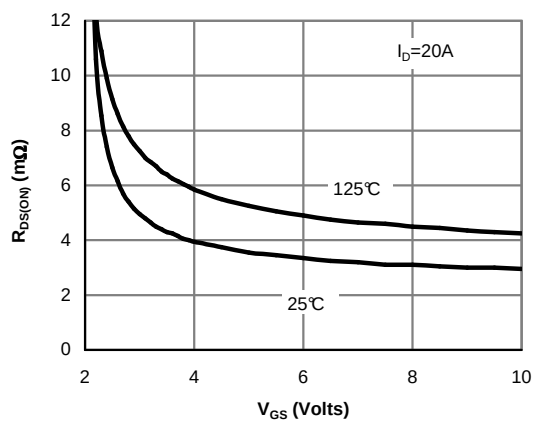
**Figure 2: Transfer Characteristics (Note E)**



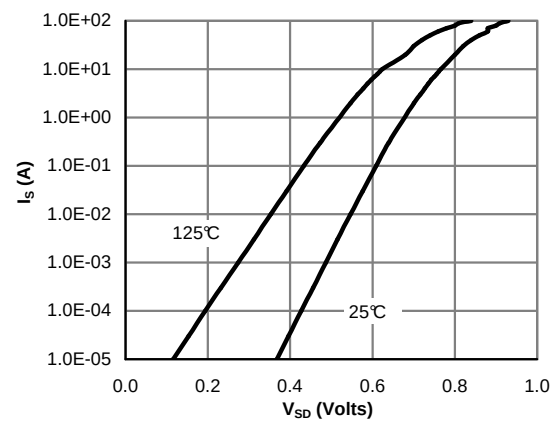
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

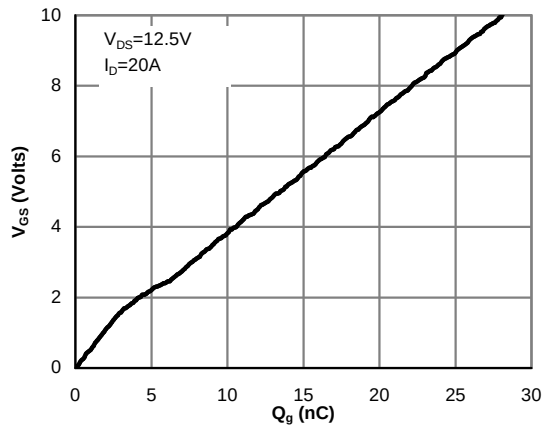


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

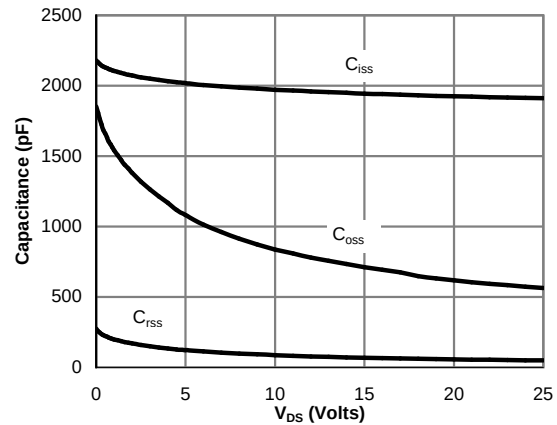


**Figure 6: Body-Diode Characteristics (Note E)**

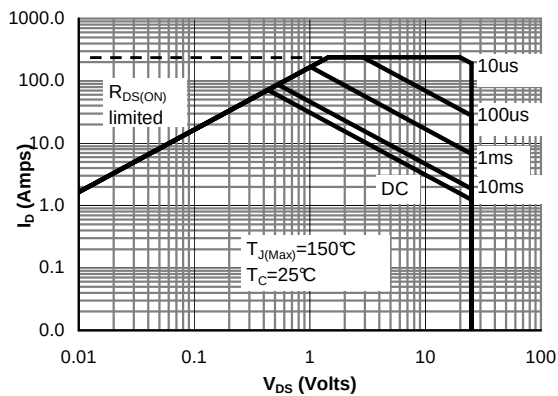
**Q1-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



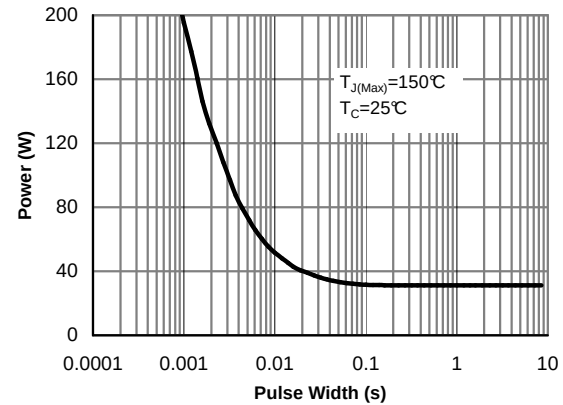
**Figure 7: Gate-Charge Characteristics**



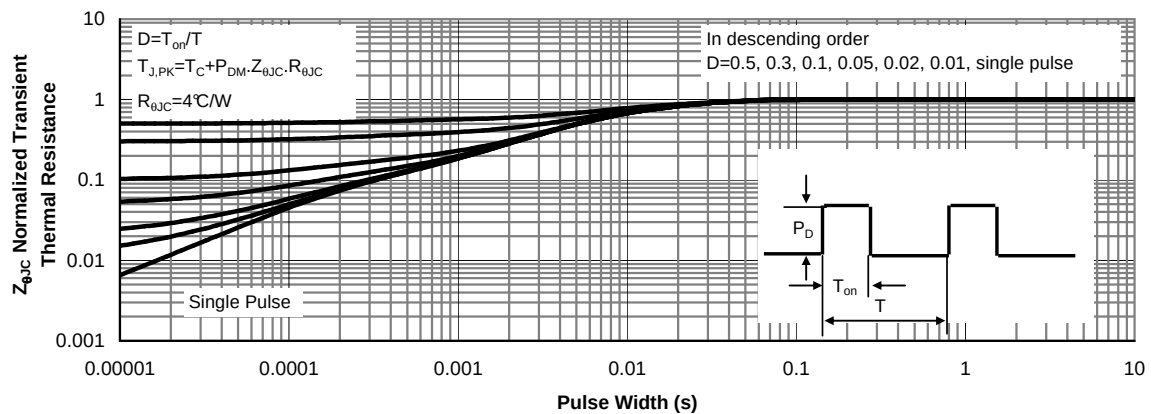
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

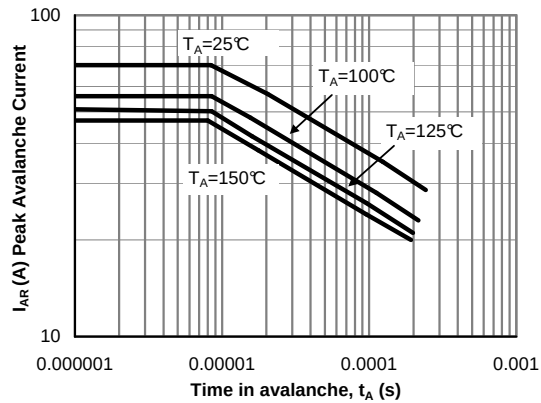


**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**

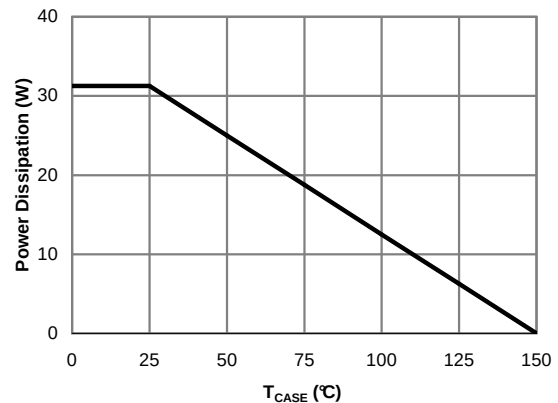


**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

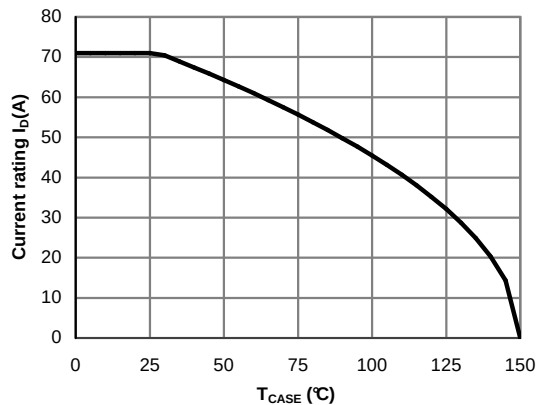
**Q1-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



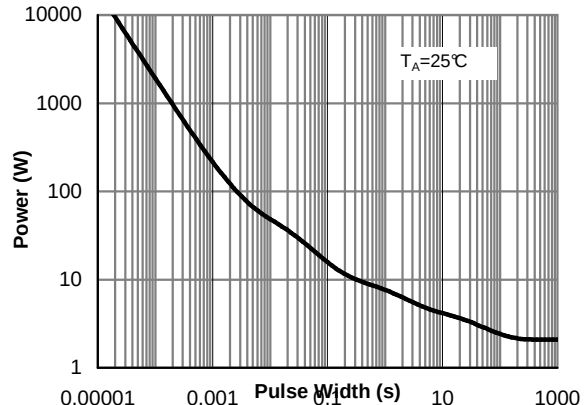
**Figure 12: Single Pulse Avalanche capability (Note C)**



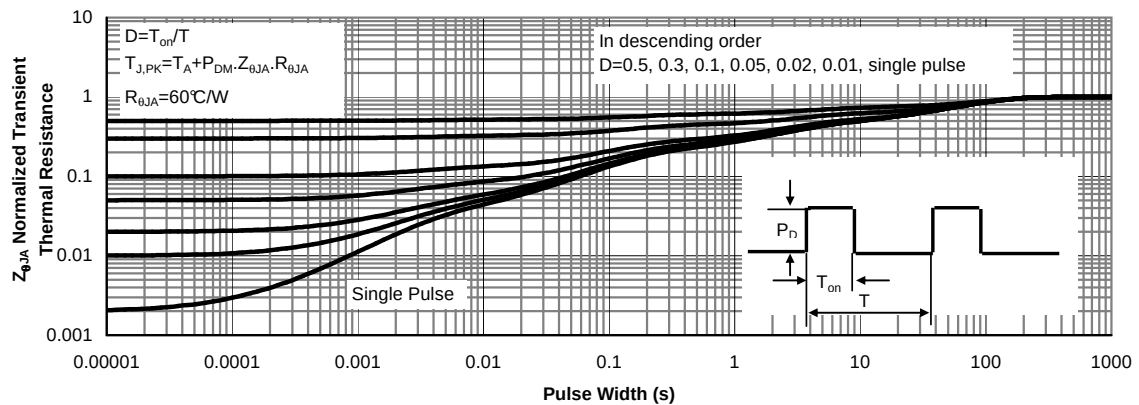
**Figure 13: Power De-rating (Note F)**



**Figure 14: Current De-rating (Note F)**



**Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)**



**Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)**

**Q2 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                                          | Conditions                                                                                  | Min  | Typ         | Max      | Units |
|-----------------------------|----------------------------------------------------|---------------------------------------------------------------------------------------------|------|-------------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                                    |                                                                                             |      |             |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                     | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                                  | 25   |             |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                    | V <sub>DS</sub> =25V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                           |      |             | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±12V                                                 |      |             | 100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                             | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                    | 0.7  | 1.2         | 1.7      | V     |
| I <sub>D(ON)</sub>          | On state drain current                             | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V                                                   | 420  |             |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance                  | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                          |      | 1.15<br>1.6 | 1.4<br>2 | mΩ    |
|                             |                                                    | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A                                                  |      | 1.4         | 1.8      | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance                           | V <sub>DS</sub> =5V, I <sub>D</sub> =20A                                                    |      | 135         |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                              | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                     |      | 0.65        | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current <sup>G</sup> |                                                                                             |      |             | 85       | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                                    |                                                                                             |      |             |          |       |
| C <sub>iss</sub>            | Input Capacitance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =12.5V, f=1MHz                                         | 4550 | 5690        | 6830     | pF    |
| C <sub>oss</sub>            | Output Capacitance                                 |                                                                                             | 1730 | 2470        | 3210     | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance                       |                                                                                             | 50   | 165         | 280      | pF    |
| R <sub>g</sub>              | Gate resistance                                    | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                            | 0.4  | 0.8         | 1.2      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                                    |                                                                                             |      |             |          |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =12.5V, I <sub>D</sub> =20A                           | 52   | 65          | 78       | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                                  |                                                                                             | 20   | 26          | 32       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                 |                                                                                             |      | 7.4         |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                  |                                                                                             |      | 5.7         |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =12.5V, R <sub>L</sub> =0.6Ω,<br>R <sub>GEN</sub> =3Ω |      | 9           |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                  |                                                                                             |      | 4.5         |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                 |                                                                                             |      | 60          |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                 |                                                                                             |      | 8           |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                   | I <sub>F</sub> =20A, dI/dt=500A/μs                                                          | 19   | 24.5        | 30       | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                 | I <sub>F</sub> =20A, dI/dt=500A/μs                                                          | 55   | 68          | 82       | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

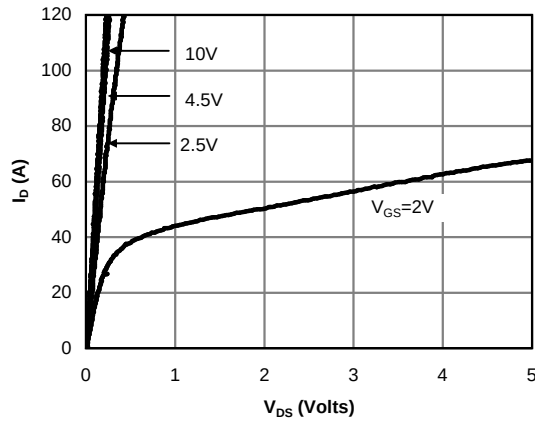
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

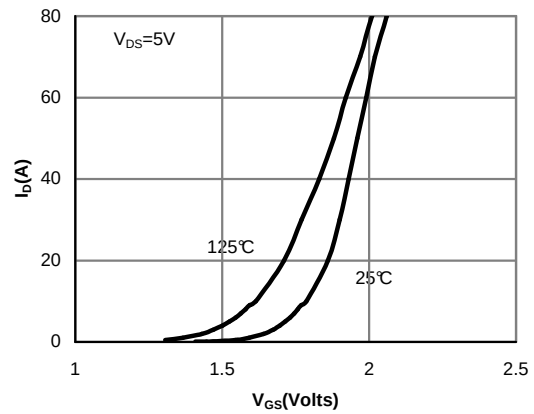
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.

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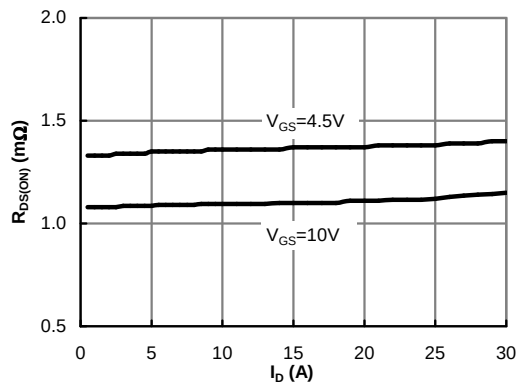
**Q2-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



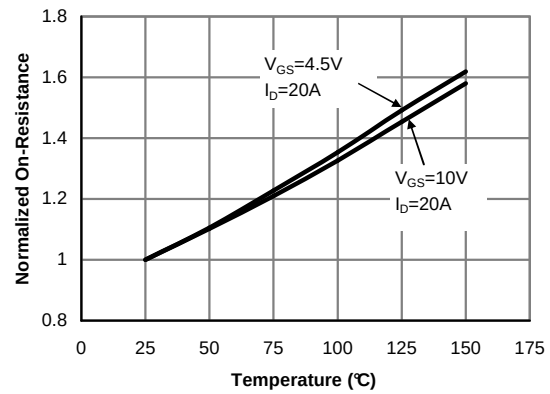
**Fig 1: On-Region Characteristics (Note E)**



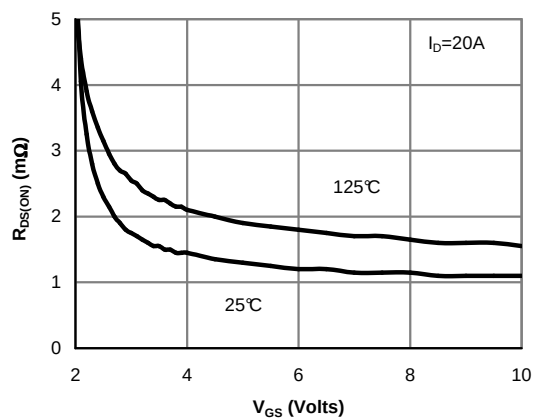
**Figure 2: Transfer Characteristics (Note E)**



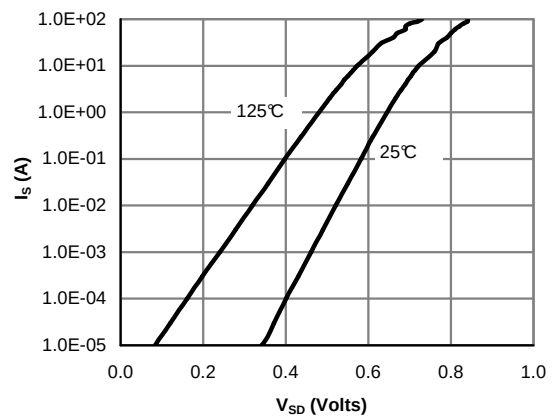
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**



**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**



**Figure 6: Body-Diode Characteristics (Note E)**

**Q2-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

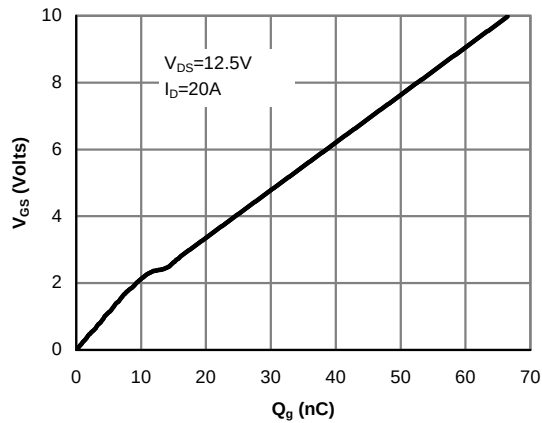


Figure 7: Gate-Charge Characteristics

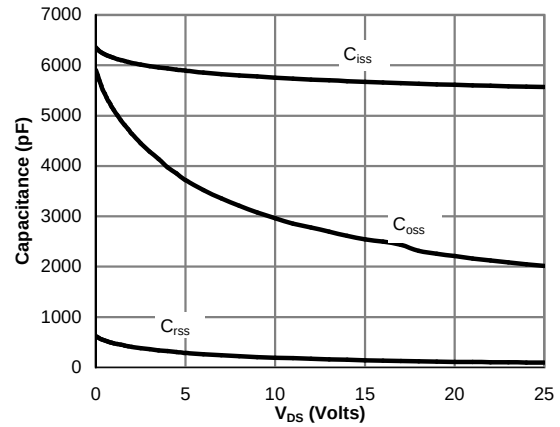


Figure 8: Capacitance Characteristics

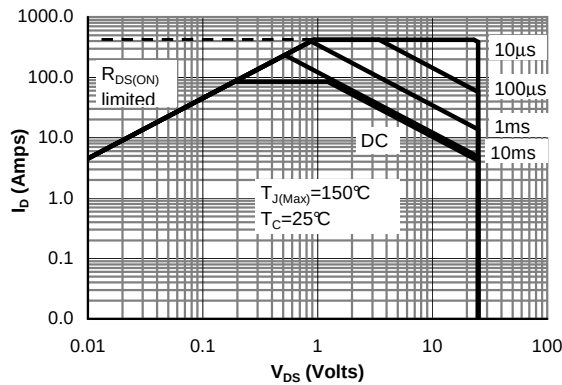


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

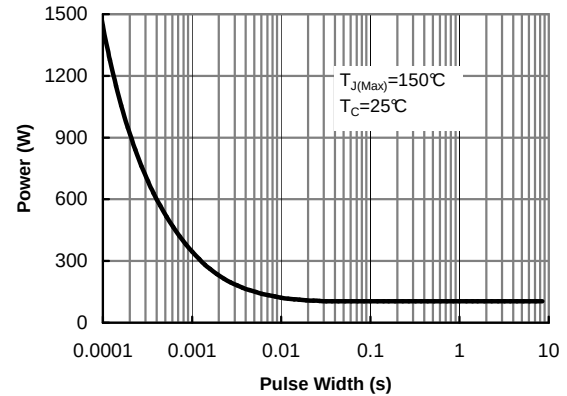


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

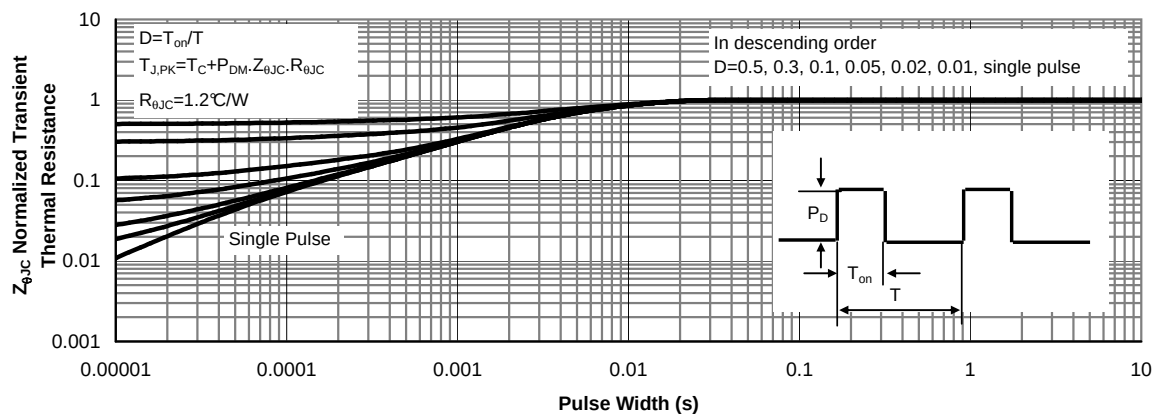
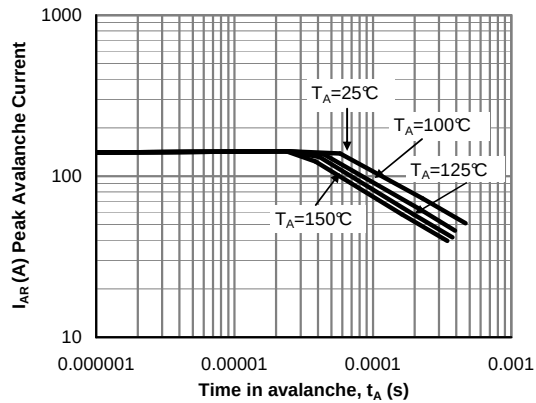


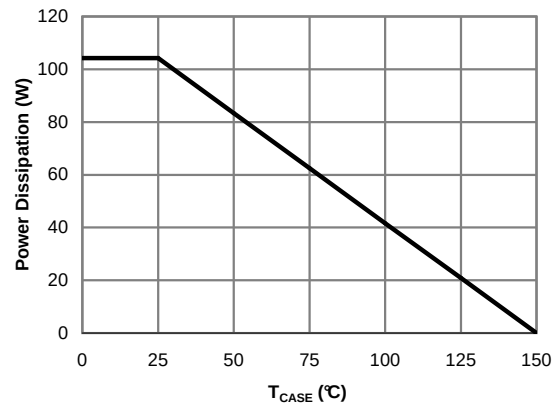
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



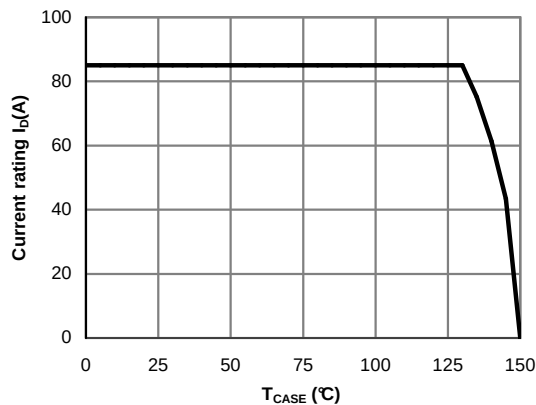
**Q2-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



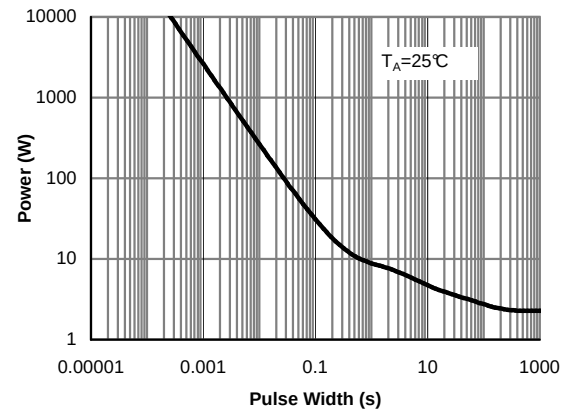
**Figure 12: Single Pulse Avalanche capability (Note C)**



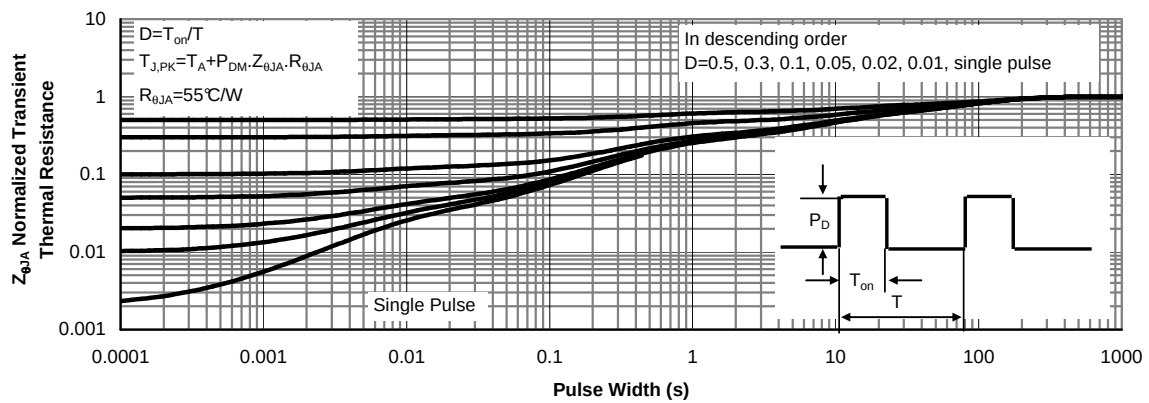
**Figure 13: Power De-rating (Note F)**



**Figure 14: Current De-rating (Note F)**

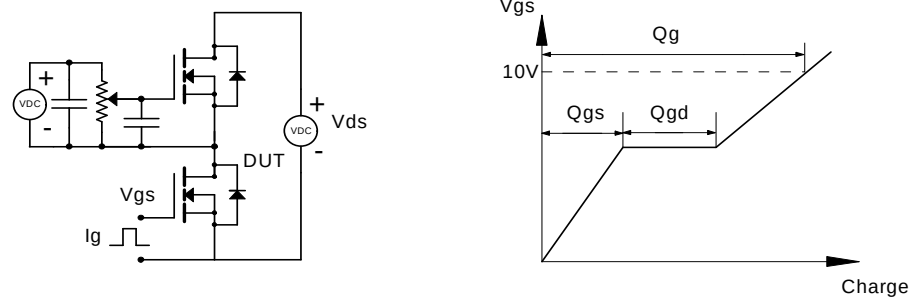


**Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note G)**

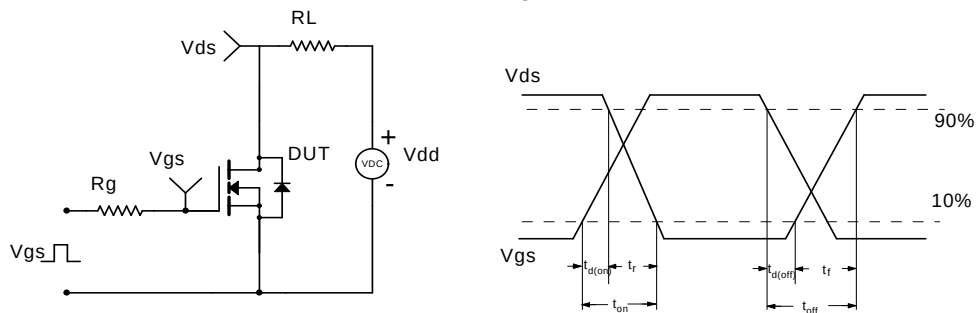


**Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)**

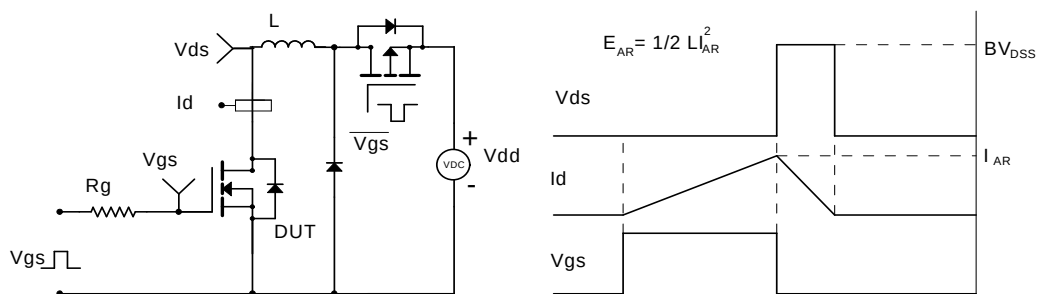
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

